Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/621,229	IBANEZ, JUAN JOSE LEGARDA
Examiner	Art Unit
Jennifer Kim	1617

SEARCHED					
Class	Subclass	Date	Examiner		
514	218	4/14/2006	JMK 7		
514	220	4/14/2006	/ ЈМК		
		·			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
		-			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor search	4/14/2006	ЈМК		
STN (registry; medicine); see attached search terms.	4/14/2006	JMK		
WEST	4/14/2006	JMK		
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